

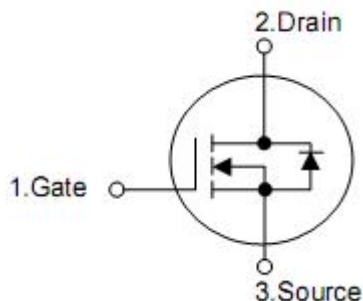
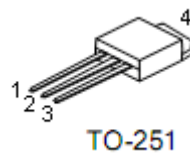
## 1. Description

This Power MOSFET is produced using KIA's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

## 2. Features

- $R_{DS(on)}=130m\ \Omega$  @  $V_{GS}=10V$
- High density cell design for ultra low  $R_{dson}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high  $E_{AS}$
- Excellent package for good heat dissipation

## 3. Pin configuration



Pin	Function
1	Gate
2	Drain
3	Source
4	Drain

#### 4. Absolutemaximum ratings

( $T_C = 25\text{ }^\circ\text{C}$ , unless otherwise noted)

Parameter	Symbol	Rating	Units
Drain-source voltage	$V_{DSS}$	150	V
Gate-source voltage	$V_{GSS}$	+20	V
Drain current continuous	$I_D$	12	A
Drain current pulsed (note 1)	$I_{DM}$	50	A
Total power dissipation	$P_D$	55	W
Operating and storage temperature range	$T_J, T_{STG}$	-55~+175	$^\circ\text{C}$

#### 5. Thermal characteristics

Parameter	Symbol	Rating	Unit
Thermal resistance,Junction-case (note 2)	$R_{thJC}$	2.7	$^\circ\text{C/W}$

## 6. Electrical characteristics

 ( $T_C=25^{\circ}\text{C}$ , unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Off characteristics</b>						
Drain-source breakdown voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	150	-	-	V
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=150V, V_{GS}=0V$	-	-	1	$\mu A$
Gate-body leakage current	Forward	$I_{GSS}$	-	-	100	nA
	Reverse				-100	nA
<b>On characteristics</b>						
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.5	2.0	2.5	V
Static drain-source on-resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=5A$	-	130	160	m $\Omega$
Forward transconductance	$g_{FS}$	$V_{DS}=15V, I_D=10A$	-	15	-	S
<b>Dynamic characteristics</b>						
Input capacitance	$C_{iss}$	$V_{DS}=25V, V_{GS}=0V,$ $f=1\text{MHz}$	-	900	-	pF
Output capacitance	$C_{oss}$		-	115	-	pF
Reverse transfer capacitance	$C_{rss}$		-	70	-	pF
<b>Switching characteristics</b>						
Turn-on delay time	$t_{d(on)}$	$V_{DD}=75V, I_D=1A,$ $R_L=75\Omega,$ $V_{GS}=10V, R_{GEN}=6\Omega$	-	8	-	ns
Rise time	$t_r$		-	10	-	ns
Turn-off delay time	$t_{d(off)}$		-	20	-	ns
Fall time	$t_f$		-	15	-	ns
Total gate charge	$Q_g$	$V_{DS}=75V, I_D=1.5A,$ $V_{GS}=10V$	-	19	-	nC
Gate-source charge	$Q_{gs}$		-	5.5	-	nC
Gate-drain charge	$Q_{gd}$		-	7	-	nC
<b>Drain-source diode characteristics and maximum ratings</b>						
Drain-source diode forward voltage(note 3)	$V_{SD}$	$V_{GS}=0V, I_{SD}=12A$	-	-	1.2	V
Continuous drain-source current (note 2)	$I_{SD}$		-	-	12	A

Notes: 1.Repetitive rating: pulse width limited by maximum junction temperature

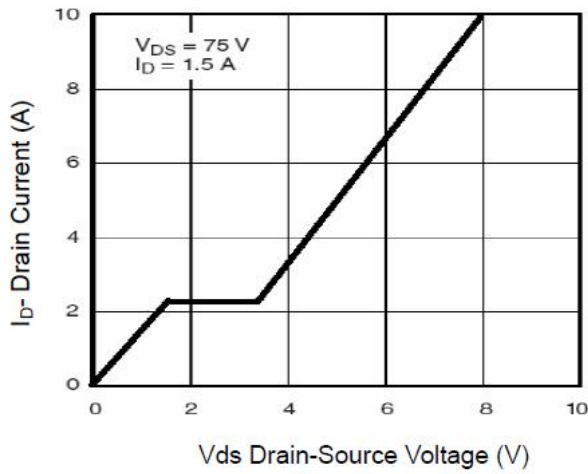
 2. Surface mounted on FR4 board,  $t \leq 10\text{sec}$ .

 3. Pulse test: pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ 

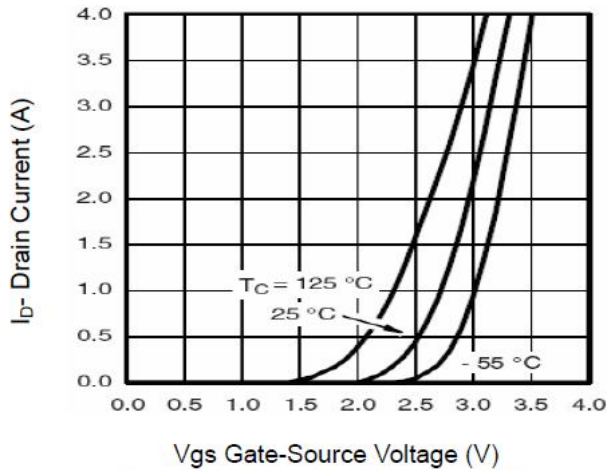
4. Guaranteed by design, not subject to production

**7. Test circuits and waveforms**

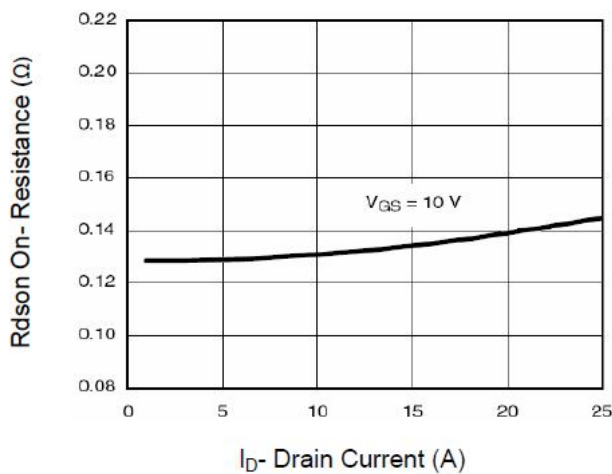
**Typical Electrical and Thermal Characteristics (Curves)**



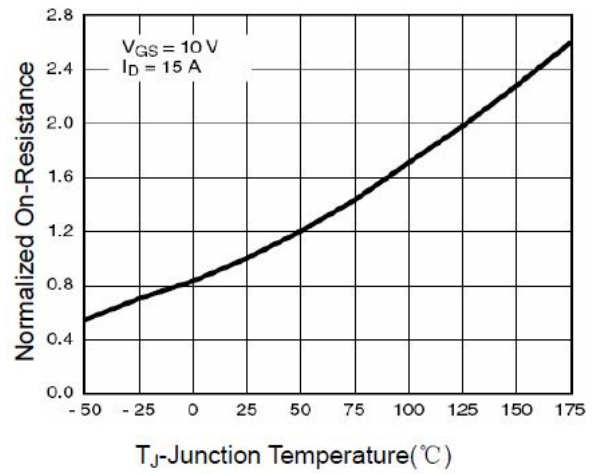
**Figure 1 Output Characteristics**



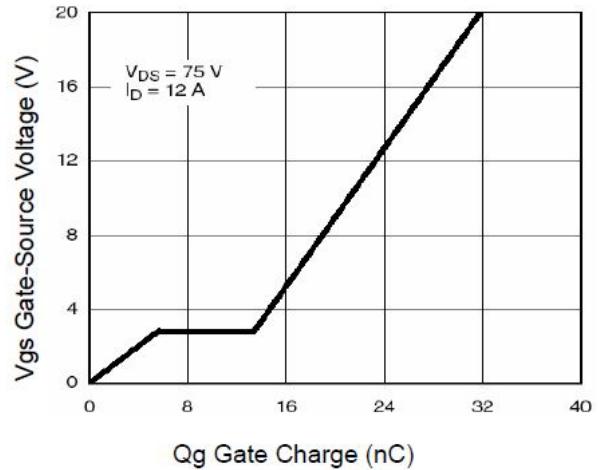
**Figure 2 Transfer Characteristics**



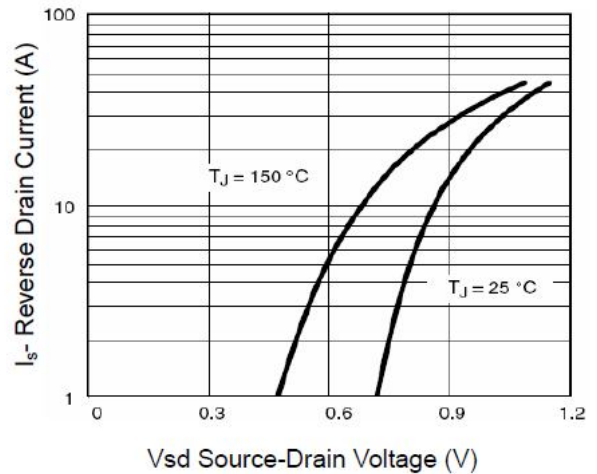
**Figure 3 Rdson- Drain Current**



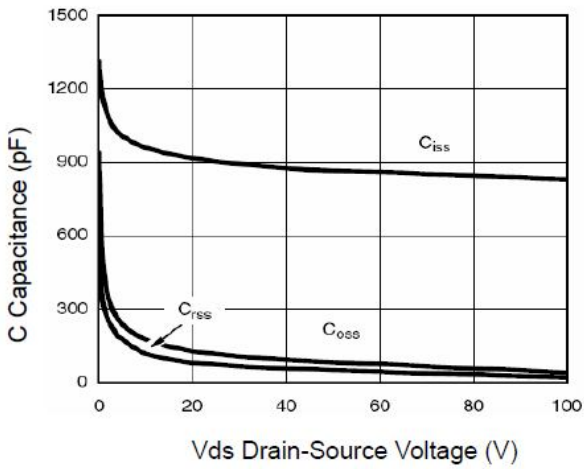
**Figure 4 Rdson- Junction Temperature**



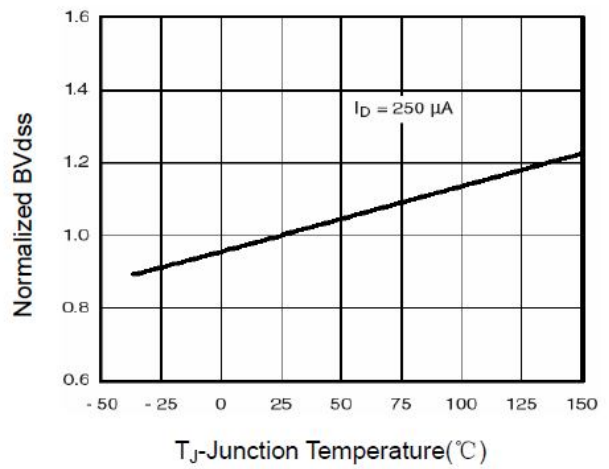
**Figure 5 Gate Charge**



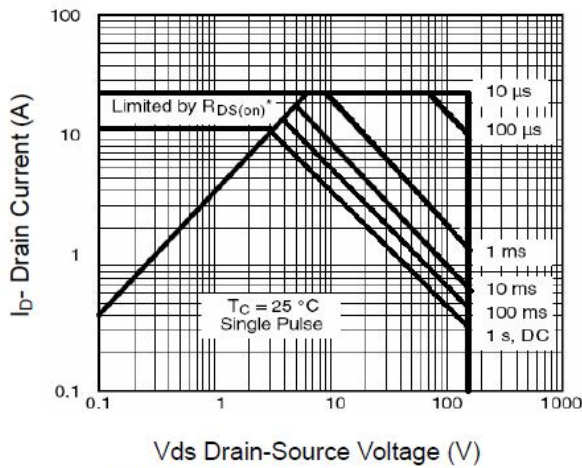
**Figure 6 Source- Drain Diode Forward**



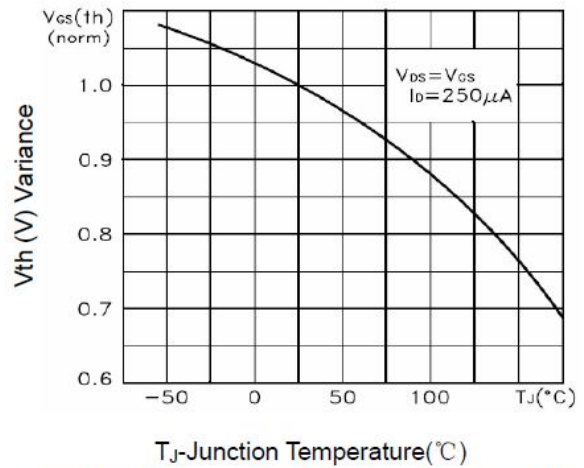
**Figure 7 Capacitance vs Vds**



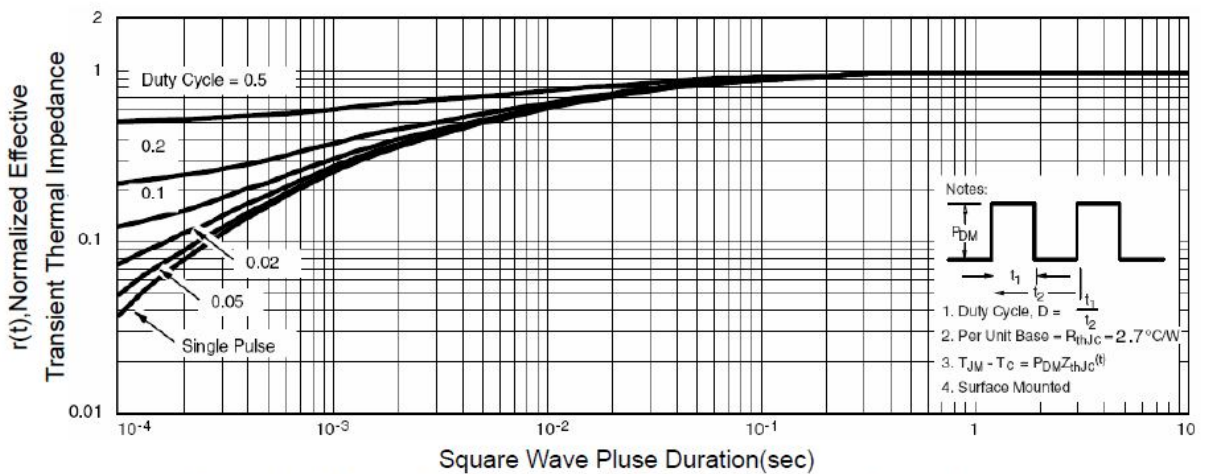
**Figure 9  $BV_{DSS}$  vs Junction Temperature**



**Figure 8 Safe Operation Area**



**Figure 10  $V_{GS(th)}$  vs Junction Temperature**



**Figure 11 Normalized Maximum Transient Thermal Impedance**